

Notice of References Cited	Application/Control No. 10/829,125		Applicant(s)/Patent Under Reexamination LONGAKER ET AL.	
	Examiner TAN TRINH		Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0142788	10-2002	Chawla et al.	455/504
*	B	US-2003/0119445	06-2003	Bromham et al.	455/39
*	C	US-5,752,197	05-1998	Rautiola, Markku	455/522
*	D	US-5,095,531	03-1992	Ito, Sadao	455/435.3
*	E	US-2003/0064744	04-2003	Zhang et al.	455/522
*	F	US-2002/0082036	06-2002	Ida et al.	455/522
*	G	US-2003/0073435	04-2003	Thompson et al.	455/428
*	H	US-2003/0045314	03-2003	Burgan et al.	455/517
*	I	US-2005/0095985	05-2005	Hafeoz, Abdulrauf	455/067.11
*	J	US-2004/0219927	11-2004	Sumner, Terence Edward	455/456.1
*	K	US-2005/0147062	07-2005	Khouaja et al.	370/332
*	L	US-6,865,169	03-2005	Quayle et al.	370/335
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	X					

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